

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Applicant:

Chris E. Barns et al.

2822 Art Unit:

Serial No .:

10/629,127

Examiner:

Khanh B. Duong

Filed:

July 29, 2003

Docket:

ITL.1016US

P16703

For:

Preventing Silicide Formation at

the Gate Electrode in a Replacement

Metal Gate Technology

Assignee:

Intel Corporation

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

REPLY TO PAPER NO. 20050207

Sir:

In response to the office action mailed March 8, 2005, please amend the abovereferenced patent application as follows:

05/26/2005 ADAVID

10629127 00000001 201504

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Date of Deposit: May 17, 2005 I hereby certify under 37 CFR 1.8(a) that this correspondence is being deposited with the United States Postal Service as first class

sufficient postage on the date indicated above and is to the Commissioner for Patents, P.O. Box 1450,